

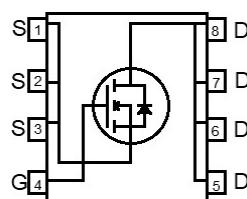


• General Description

It combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$.

• Features

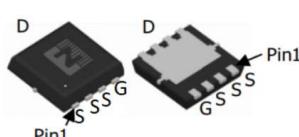
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance



$V_{DS} = 80V$
 $R_{DS(ON)} = 7.5m\Omega$
 $I_D = 51A$

• Application

- BLDC Motor driver
- DC-DC
- Load switch



DFN3*3



HF

• Ordering Information:

Part NO.	ZMS080N08M
Marking	080N08
Packing Information	REEL TAPE
Basic ordering unit (pcs)	5000

• Absolute Maximum Ratings ($T_C=25^\circ C$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		80	V
Gate-Source Voltage	V_{GS}		± 20	V
Continuous Drain Current	I_D	$T_C=25^\circ C$	51	A
	I_D	$T_C=75^\circ C$	42	A
	I_D	$T_C=100^\circ C$	36	A
Pulsed Drain Current	I_{DM}	Pulsed; $t_p \leq 10 \mu s$; $T_{mb} = 25^\circ C$	204	A
Total Power Dissipation	P_D	$T_C=25^\circ C$	50	W
Total Power Dissipation	P_D	$T_A=25^\circ C$	3.3	W
Operating Junction Temperature	T_J		-55 to +175	°C
Storage Temperature	T_{STG}		-55 to +175	°C
Single Pulse Avalanche Energy	E_{AS}	$L=0.1mH$, $V_{GS}=10V$, $R_g=25\Omega$,	50	mJ
		$L=0.5mH$, $V_{GS}=10V$, $R_g=25\Omega$,	90	mJ
ESD Level (HBM)			CLASS 2	



•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}		-	3	°C/W
Thermal resistance, junction-ambient ⁽¹⁾	R _{thJA}		-	45	°C/W
Soldering temperature (total time<10s)	T _{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250uA	80			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250uA	1.3	1.7	2.5	V
Drain-Source Leakage Current	I _{DSS}	V _{GS} =0V, V _{DS} = 80V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±20V, V _{DS} = 0V			100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =10V, I _D = 10A		7.5	10	mΩ
		V _{GS} =4.5V, I _D = 8A		11	14	mΩ
Forward Transconductance	g _{FS}	V _{DS} =5V, I _{SD} = 10A		14		S
Diode Forward Voltage	V _{FSD}	V _{GS} =0V, I _{SD} = 10A			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz, V _{DS} =25V	-	1720	-	pF
Output capacitance	C _{oss}		-	1250	-	
Reverse transfer capacitance	C _{rss}		-	220	-	
Gate Resistance	R _g	f = 1MHz	-	1.6		Ω
Total gate charge	Q _g	V _{DD} = 15V, I _D = 10A, V _{GS} = 10V	-	24	-	nC
	Q _g (4.5v)		-	12	-	
Gate - Source charge	Q _{gs}		-	4.4	-	
Gate - Drain charge	Q _{gd}		-	4.5	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =10V, V _{DS} =15V, R _G =3.0Ω, I _D =20A	-	7.3	-	ns
Turn-ON Rise time	t _r		-	13	-	ns
Turn-Off Delay time	t _{D(off)}		-	20	-	ns
Turn-Off Fall time	t _f		-	7.5	-	ns
Reverse Recovery Time	t _{rr}	V _{DD} =20V, dI _S /dt = 100A/us, I _S =20A	-	39	-	ns
Reverse Recovery Charge	Q _{rr}		-	30	-	nC



Fig.1 Gate-Charge Characteristics

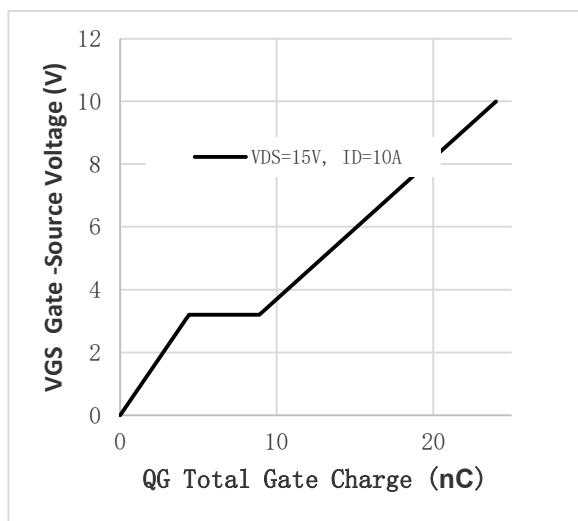


Fig.2 Capacitance Characteristics

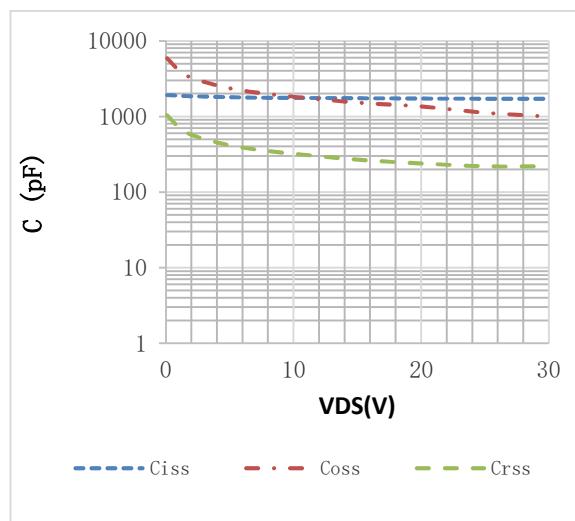


Fig.3 Power Dissipation

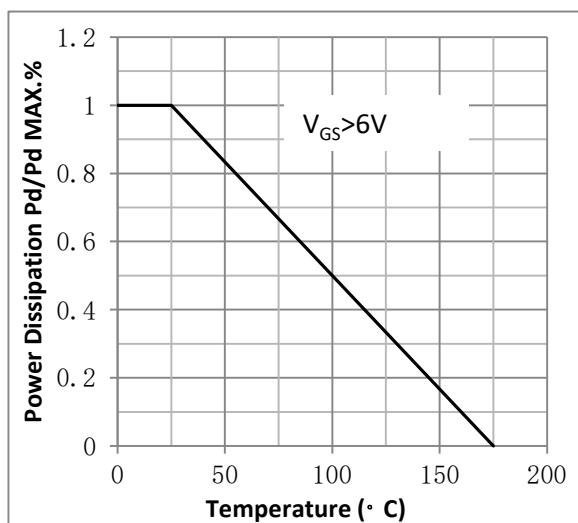


Fig.4 Typical output Characteristics

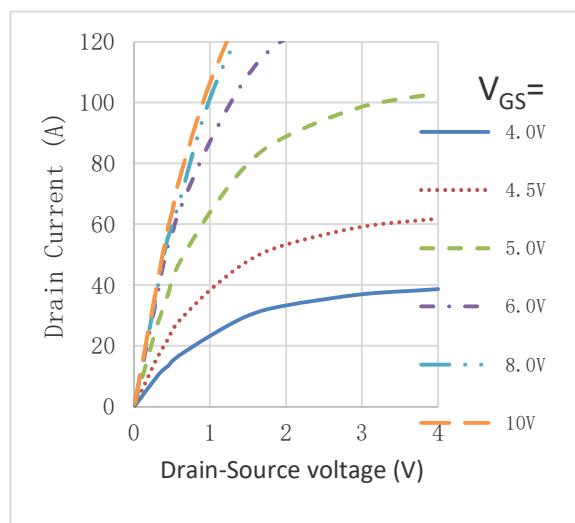


Fig.5 Threshold Voltage V.S Junction Temperature

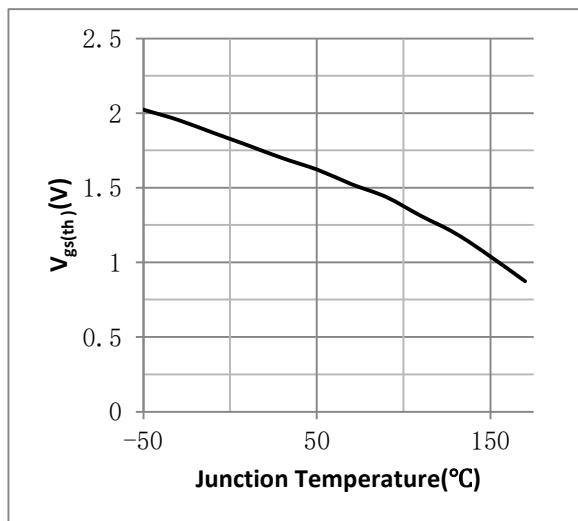


Fig.6 Resistance V.S Drain Current

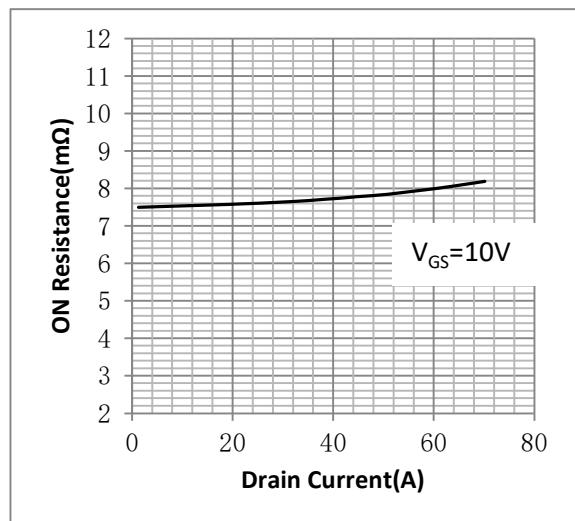


Fig.7 On-Resistance VS Gate Source Voltage

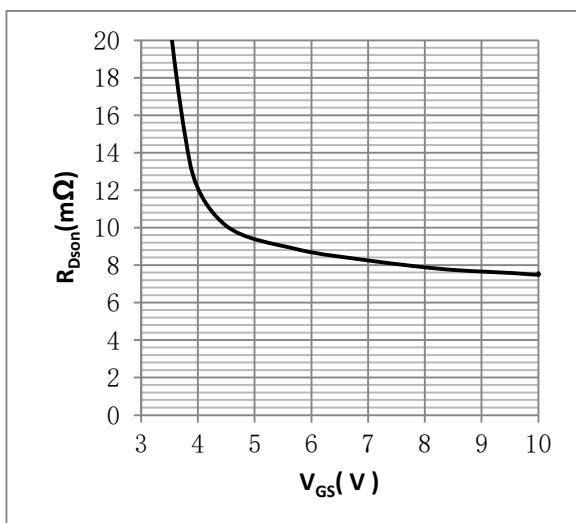


Fig.8 On-Resistance V.S Junction Temperature

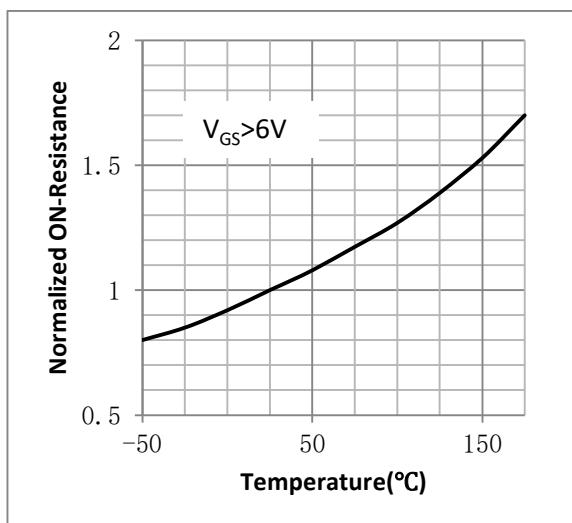


Figure 9. Diode Forward Voltage vs. Current

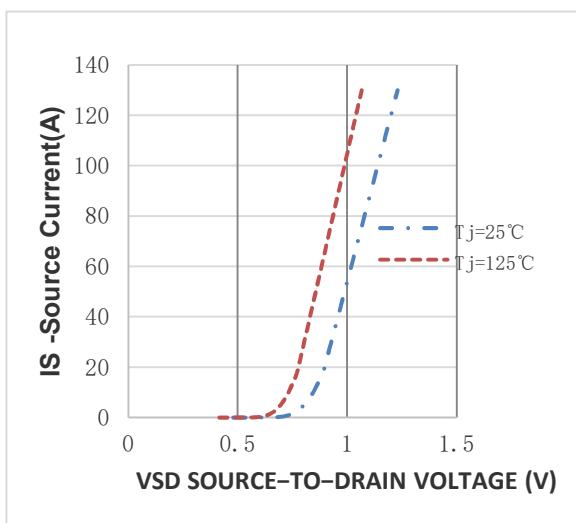


Figure 10. Transfer Characteristics

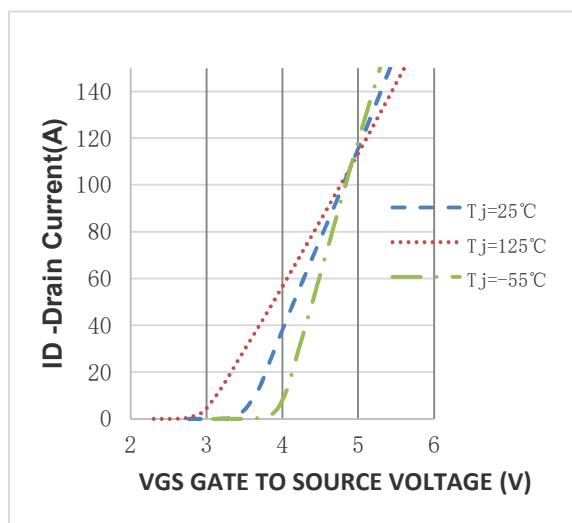
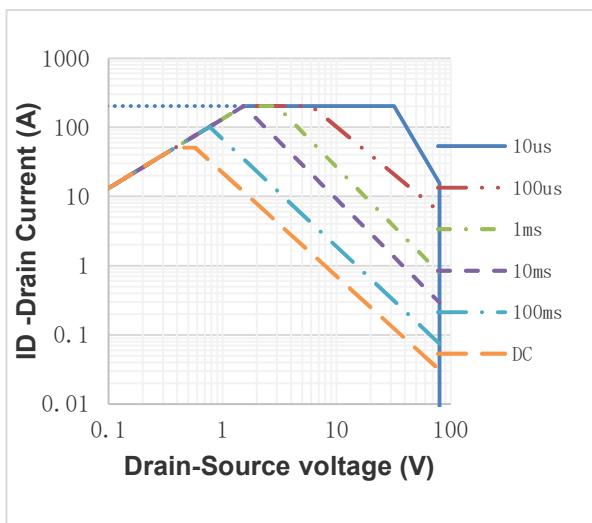
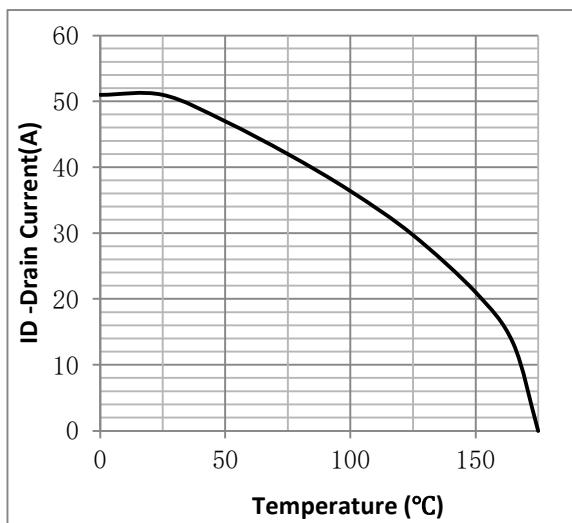
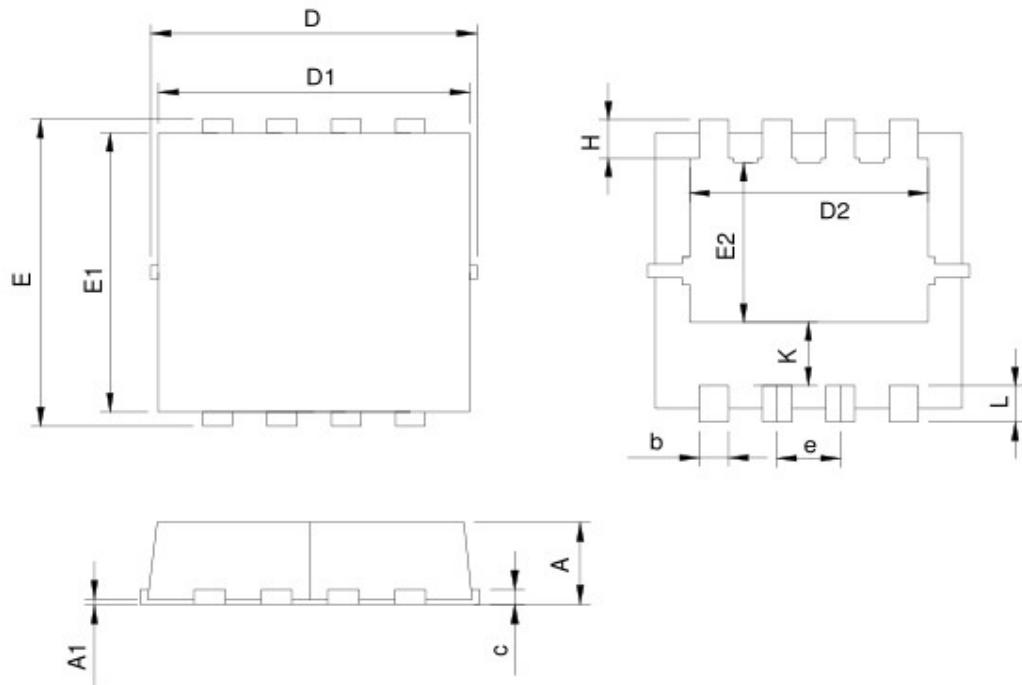


Fig.11 SOA Maximum Safe Operating Area

Fig.12 ID vs. Case Temperature^②

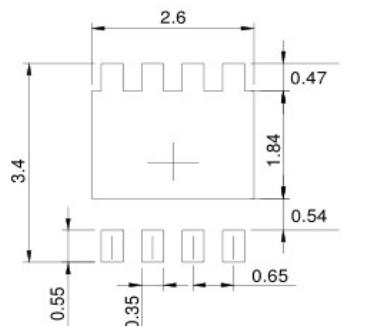


•DFN3*3 Package Outline



SYMBOL	DFN3.3x3.3-8			
	MILLIMETERS		INCHES	
	MIN.	MAX.	MIN.	MAX.
A	0.70	1.00	0.028	0.039
A1	0.00	0.05	0.000	0.002
b	0.25	0.35	0.010	0.014
c	0.14	0.20	0.006	0.008
D	3.10	3.50	0.122	0.138
D1	3.05	3.25	0.120	0.128
D2	2.35	2.55	0.093	0.100
E	3.10	3.50	0.122	0.138
E1	2.90	3.10	0.114	0.122
E2	1.64	1.84	0.065	0.072
e	0.65 BSC		0.026 BSC	
H	0.32	0.52	0.013	0.020
K	0.59	0.79	0.023	0.031
L	0.25	0.55	0.010	0.022

RECOMMENDED LAND PATTERN



UNIT: mm

**Note:**

- ① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;
- ② Practically the current will be limited by PCB, thermal design and operating temperature. VGS=10V.

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Revision History

Version	Date	Change
A	2021.12.10	
B	2022.11.7	1.Add dynamic characteristics 2.Fig1~12 modify 3.Add It is suitable for automotive application.4.Add Dynamic characteristics